

FUJI POWER MOSFET Super FAP-G Series

N-CHANNEL SILICON POWER MOSFET

Features

- High speed switching
- Low on-resistance
- No secondary breakdown
- Low driving power
- Avalanche-proof

Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

Maximum ratings and characteristic Absolute maximum ratings

(T_c=25°C unless otherwise specified)

Item	Symbol	Ratings	Unit
Drain-source voltage	V _{DS}	200	V
	V _{DSX} *5	170	V
Continuous drain current	I _D	±13	A
Pulsed drain current	I _{D(puls)}	±52	A
Gate-source voltage	V _{GS}	±30	V
Non-repetitive Avalanche current	I _{AS} *2	13	A
Maximum Avalanche Energy	E _{AS} *1	175	mJ
Maximum Drain-Source dV/dt	dV/dt *4	20	kV/μs
Peak Diode Recovery dV/dt	dV/dt *3	5	kV/μs
Max. power dissipation	P _D	T _a =25°C	2.02
		T _c =25°C	50
Operating and storage temperature range	T _{ch}	+150	°C
	T _{stg}	-55 to +150	°C

*1 L=1.65mH, V_{CC}=48V *2 T_{ch}≤150°C *3 I_F≤-I_D, -di/dt=50A/μs, V_{CC}≤BV_{DSS}, T_{ch}≤150°C

*4 V_{DS} ≤ 200V *5 V_{GS}=-30V

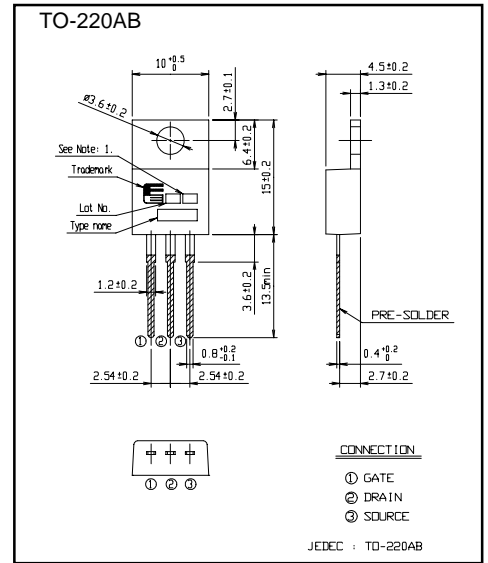
Electrical characteristics (T_c =25°C unless otherwise specified)

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	V _{(BR)DSS}	I _D = 250μA V _{GS} =0V	200			V
Gate threshold voltage	V _{GS(th)}	I _D = 250μA V _{DS} =V _{GS}	3.0		5.0	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =200V V _{GS} =0V			25	μA
		V _{DS} =160V V _{GS} =0V			250	
Gate-source leakage current	I _{GSS}	V _{GS} =±30V V _{DS} =0V		10	100	nA
Drain-source on-state resistance	R _{DS(on)}	I _D =6.5A V _{GS} =10V		131	170	mΩ
Forward transconductance	g _{fs}	I _D =6.5A V _{DS} =25V	5.5	11		S
Input capacitance	C _{iss}	V _{DS} =75V		770	1155	pF
Output capacitance	C _{oss}	V _{GS} =0V		110	165	
Reverse transfer capacitance	C _{rss}	f=1MHz		5	7.5	
Turn-on time t _{on}	td(on)	V _{CC} =48V I _D =6.5A		12	18	ns
	t _r	V _{GS} =10V		2.6	3.9	
Turn-off time t _{off}	td(off)	R _{GS} =10 Ω		22	33	
	t _f			6.1	9.2	
Total Gate Charge	Q _G	V _{CC} =100V		21	31.5	nC
Gate-Source Charge	Q _{GS}	I _D =13A		8	12	
Gate-Drain Charge	Q _{GD}	V _{GS} =10V		5	7.5	
Avalanche capability	I _{AV}	L=100μH T _{ch} =25°C	13			A
Diode forward on-voltage	V _{SD}	I _F =13A V _{GS} =0V T _{ch} =25°C		1.10	1.65	V
Reverse recovery time	t _{rr}	I _F =13A V _{GS} =0V		0.15		μs
Reverse recovery charge	Q _{rr}	-di/dt=100A/μs T _{ch} =25°C		0.88		μC

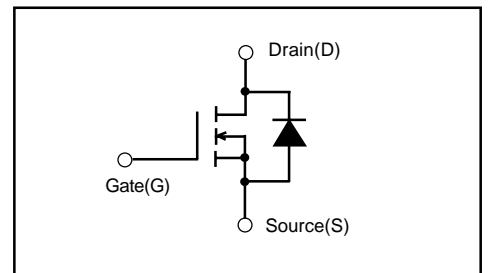
Thermal characteristics

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	R _{th(ch-c)}	channel to case			2.5	°C/W
	R _{th(ch-a)}	channel to ambient			62.0	°C/W

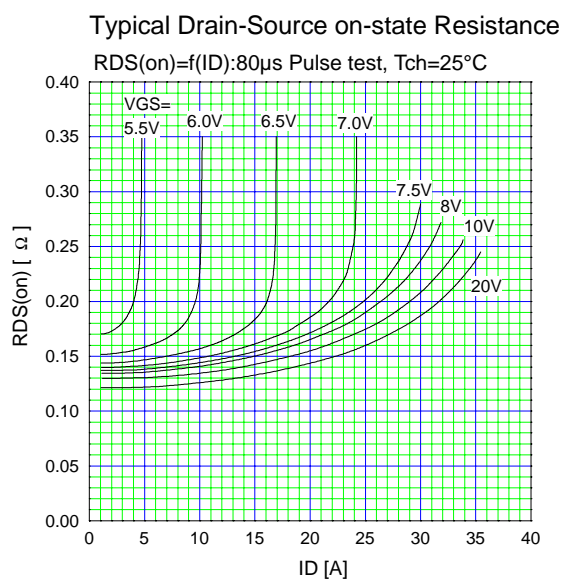
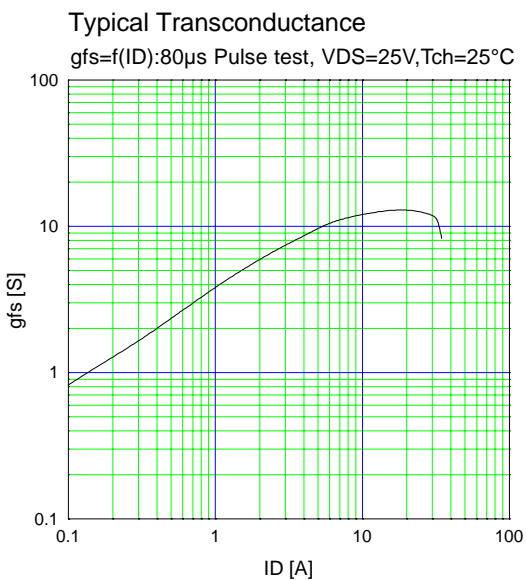
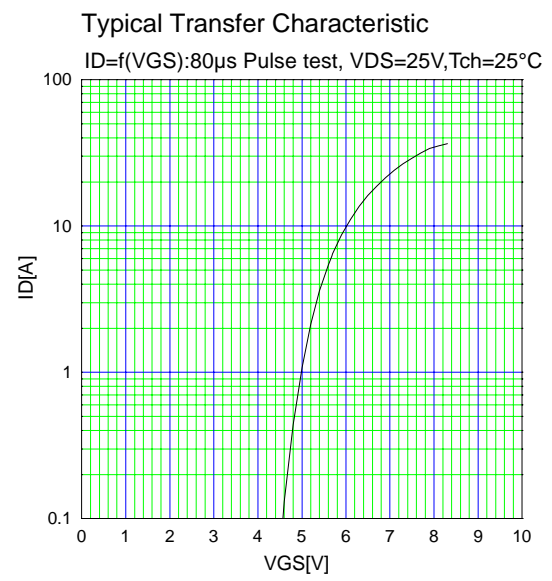
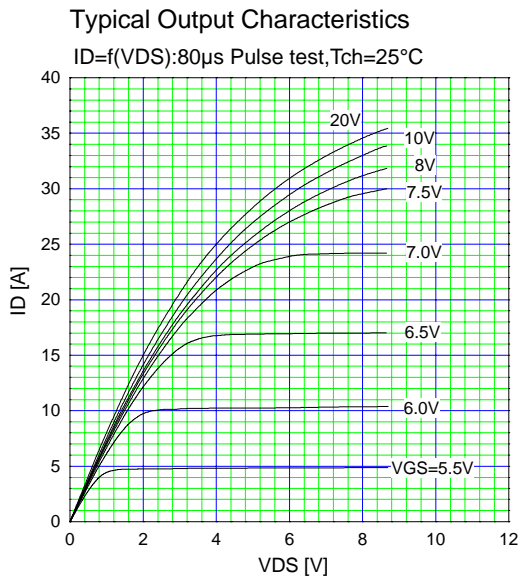
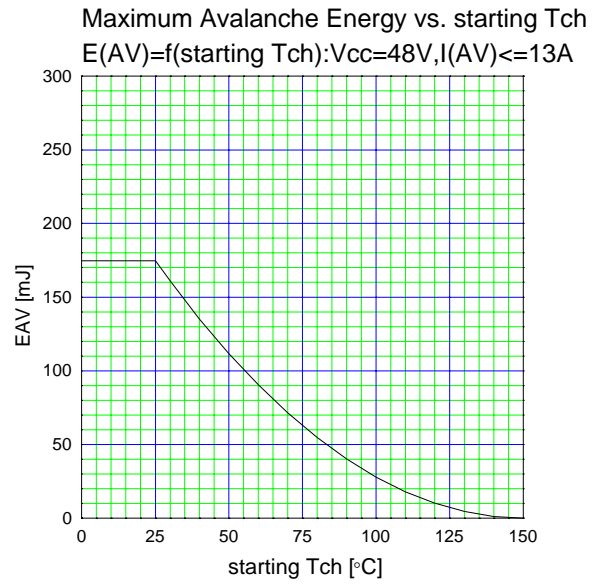
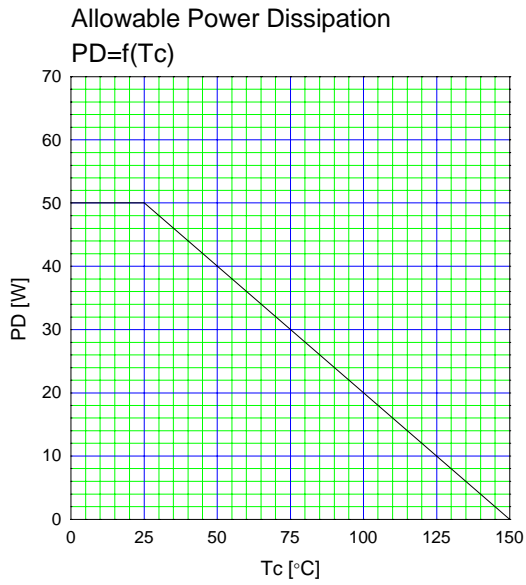
Outline Drawings (mm)



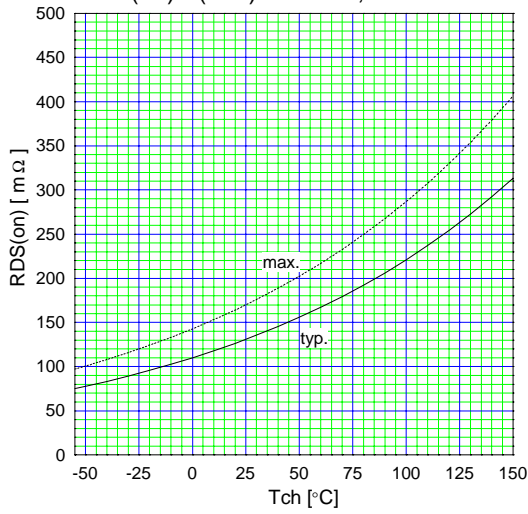
Equivalent circuit schematic



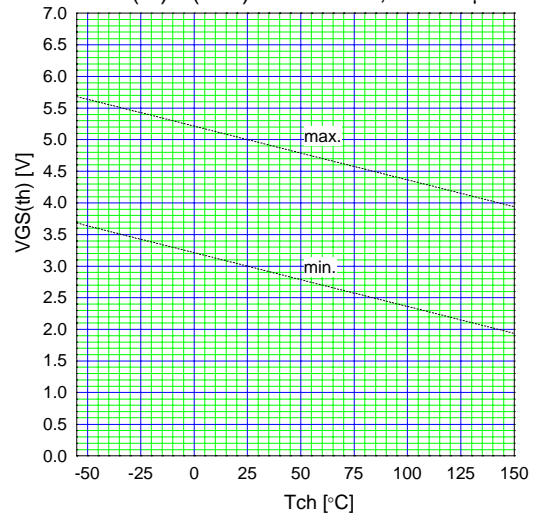
Characteristics



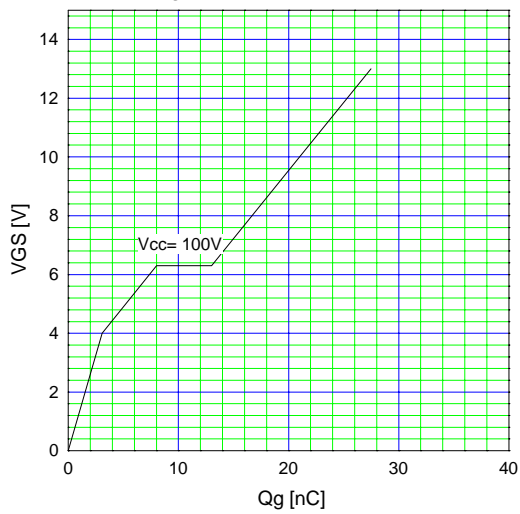
Drain-Source On-state Resistance
 $R_{DS(on)}=f(T_{ch}):I_D=6.5A, V_{GS}=10V$



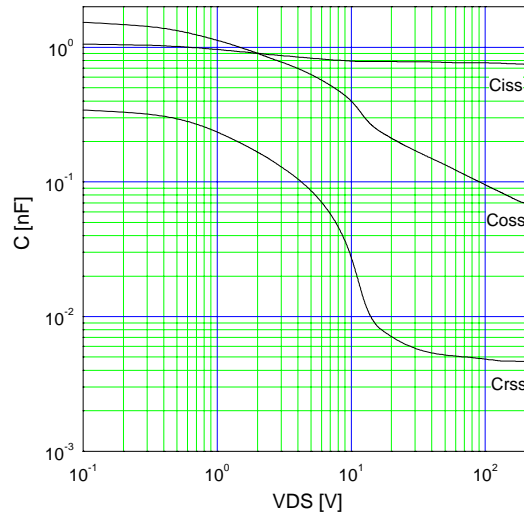
Gate Threshold Voltage vs. Tch
 $V_{GS(th)}=f(T_{ch}):V_{DS}=V_{GS}, I_D=250\mu A$



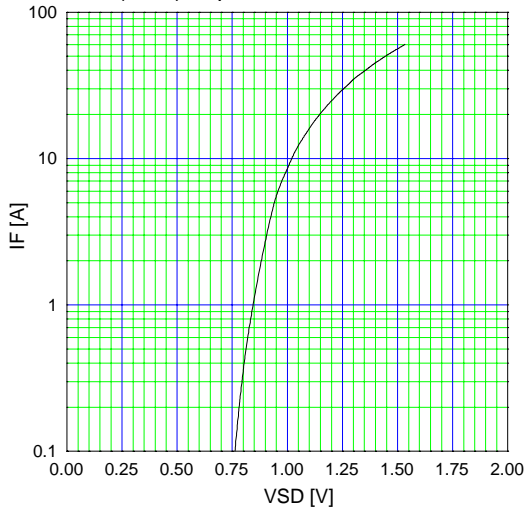
Typical Gate Charge Characteristics
 $V_{GS}=f(Q_g):I_D=13A, T_{ch}=25^\circ C$



Typical Capacitance
 $C=f(V_{DS}):V_{GS}=0V, f=1MHz$



Typical Forward Characteristics of Reverse Diode
 $I_F=f(V_{SD}):80\mu s$ Pulse test, $T_{ch}=25^\circ C$



Typical Switching Characteristics vs. ID
 $t=f(I_D):V_{CC}=48V, V_{GS}=10V, R_G=10\Omega$

